Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/752,046	SCHIER, JOHN ELMORE	
Examiner	Art Unit	
Christopher A. Revak	2131	

SEARCHED					
Class	Subclass	Date	Examiner		
NONE	NONE	5/27/2006	CR		
					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
713	200-202	11/23/2004	CR		
709	204,206	11/23/2004	CR		
705	50,56	11/23/2004	CR		
713/150,168,175,176		11/23/2004	CR		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS Text Search USPAT, US PGPUB, USOCR, DERWENT, JPO, EPO, IBM TDB	5/27/2006	CR		
DIALOG Text Search COMPSCI, ELECTRON, SOFTWARE	5/27/2006	CR		
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